

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10662789	CHEFALAS ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Veillard, Jacques	2165

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
707	1-4, 5, 100-102, 200-202, 205 With Limited Keywords (Updated 7/8/2009)	12/07/2006	J.V
709	203, 220-225, 236, 246 With limited Keywords (Updated 7/8/2009)	12/07/2006	J.V
715	501.1, 513, 826 With limited Keywords (Updated 7/8/2009)	12/07/2006	J.V

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EIC Plus database search	11/21/2006	J.V
Consulted with G. Robinson P.E AU 2168, reviewed the claims	12/06/2006	J.V
Consulted with L.Wassum	12/07/2006	J.V
Consulted with 101 panel, M. Bookbinder confirm that claims 8, and 17-23 are non-statutory	12/07/2006	J.V
East Electronic Database search Using Limited Keywords (Updated 7/8/2009)	12/07/2006	J.V
Inventor search for possible double patenting	12/07/2006	J.V
New EIC Plus Databases Search (New Search Updated 7/8/2009)	12/18/2008	J.V
Consulted with SDPE AJ. Neveen reviewed the amended claims suggested search and prior arts	7/7/2009	J.V

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>